

承 認 書

SPECIFICATION FOR APPROVAL

客戶名稱
 CUSTOMER : _____
 客戶料號
 CUSTOMER'S P/N : _____
 料號
 PART NUMBER : WAN2012F245C0X
 規格
 DESCRIPTION : Chip Antenna 2012 L Ant 2.45G Type 02,04,06
 版本
 VERSION : V2.3
 日期
 ISSUE DATE : 2018/01/30

客 戶 承 認 CUSTOMER APPROVED

工 程 部 R&D CENTER		
承 認 APPROVAL	確 認 CHECKED	製 作 DRAWN
Ray	James	Thor



萬誠科技股份有限公司

112 台北市北投區中央南路二段 36 號 3 樓

電話: (02) 2898-2220

傳真: (02) 2898-5055

OneWave Electronic Co., Ltd.

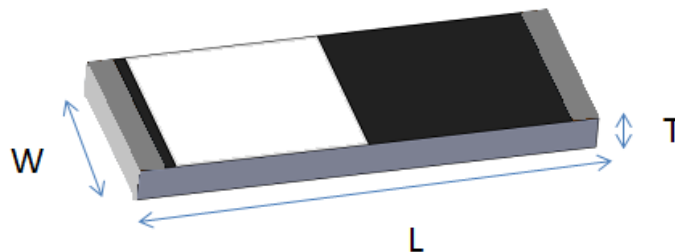
2F., No.163, Sec. 1, Xi'an St., Beitou Dist.,
Taipei City 112, Taiwan

TEL: +886 2 2898-2220

FAX: +886 2 2898-5055

2012 Chip antenna

For Bluetooth / WLAN Applications



P/N: WAN2012F245C02
 WAN2012F245C04
 WAN2012F245C06

	Dimension (mm)
L	2.05 ± 0.20
W	1.23 ± 0.20
T	0.45 ± 0.20

Part Number Information

WAN 2012 F 245 C 0X
 A B C D E F

A	Product Series	Antenna
B	Dimension L x W	2.05X1.23mm (± 0.2mm)
C	Material	High K material
D	Working Frequency	2.4 ~ 2.5GHz
E	Feeding mode	PIFA & Single Feeding
F	Antenna type	0X=02,04,06 / Type=02,04,06

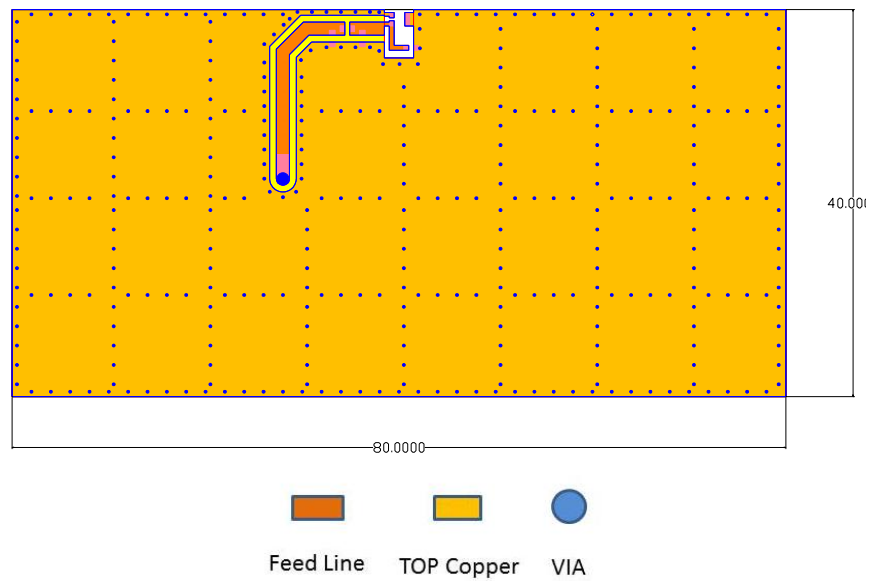
1. Electrical Specification

Specification		
Part Number	WAN2012F245C02 WAN2012F245C04 WAN2012F245C06	
Central Frequency	2450	MHz
Bandwidth	85 (Min.)	MHz
Return Loss	-6.5 (Max)	dB
Peak Gain	1.72	dBi
Impedance	50	Ohm
Operating Temperature	-40 ~ +85	°C
Maximum Power	4	W
Resistance to Soldering Heats	10 (@ 260°C)	sec.
Polarization	Linear	
Azimuth Beamwidth	Omni-directional	
Termination	Ni / Au (Leadless)	

Remark : Bandwidth & Peak Gain was measured under evaluation board of next page

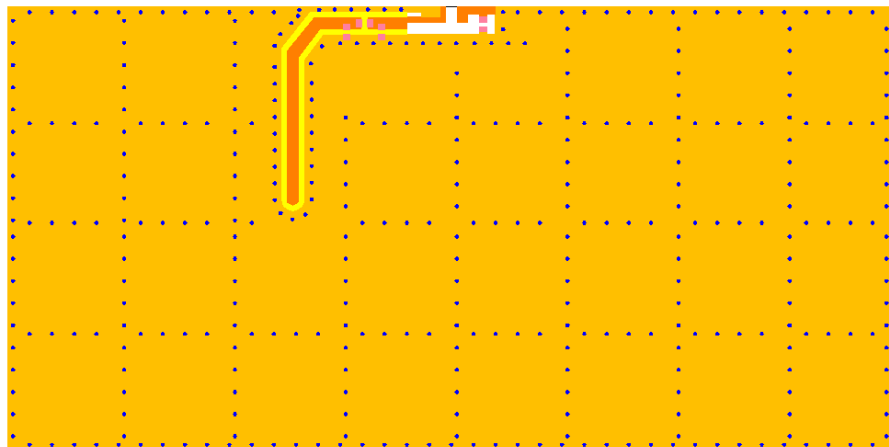
2. Recommended PCB Pattern

Evaluation Board Dimension (board size 80x40mm)



2nd Evaluation Board Dimension

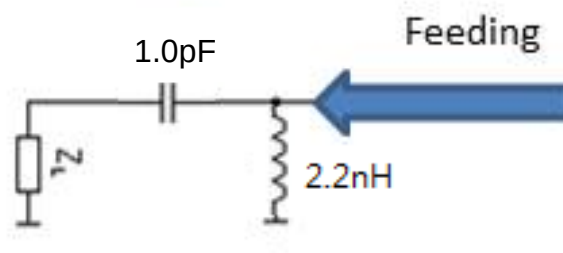
Evaluation Board Dimension (board size 80x40mm)



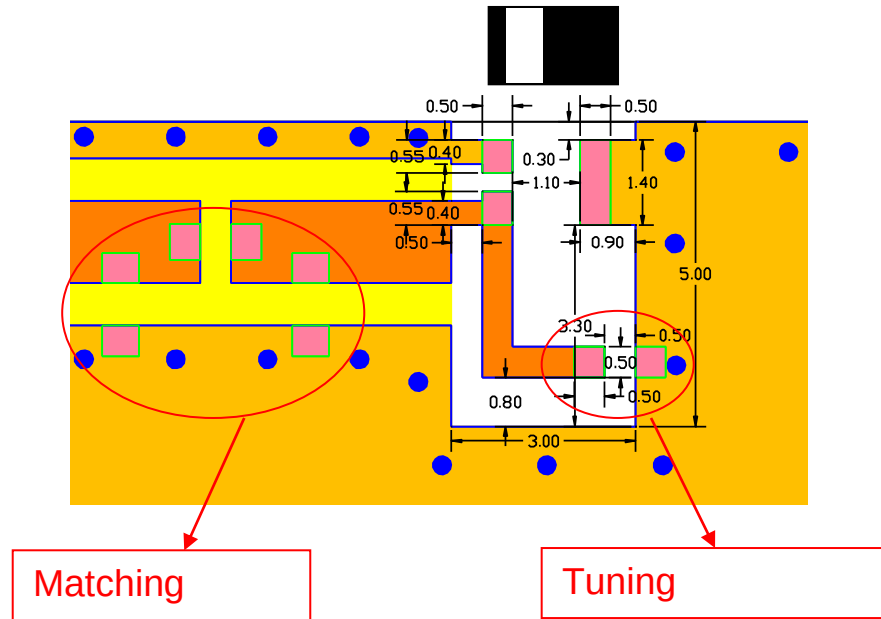
Suggested Matching Circuit

重要資訊：

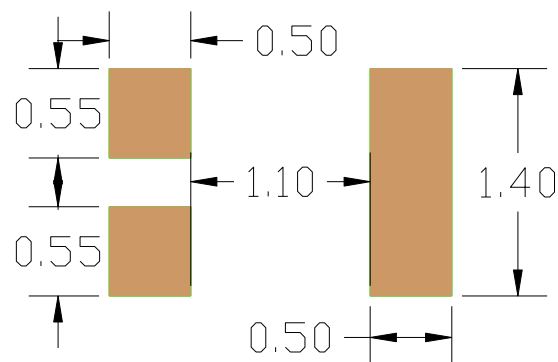
匹配元件建議使用精準度 $\pm 1\%$ 以下的電感、電容、電阻



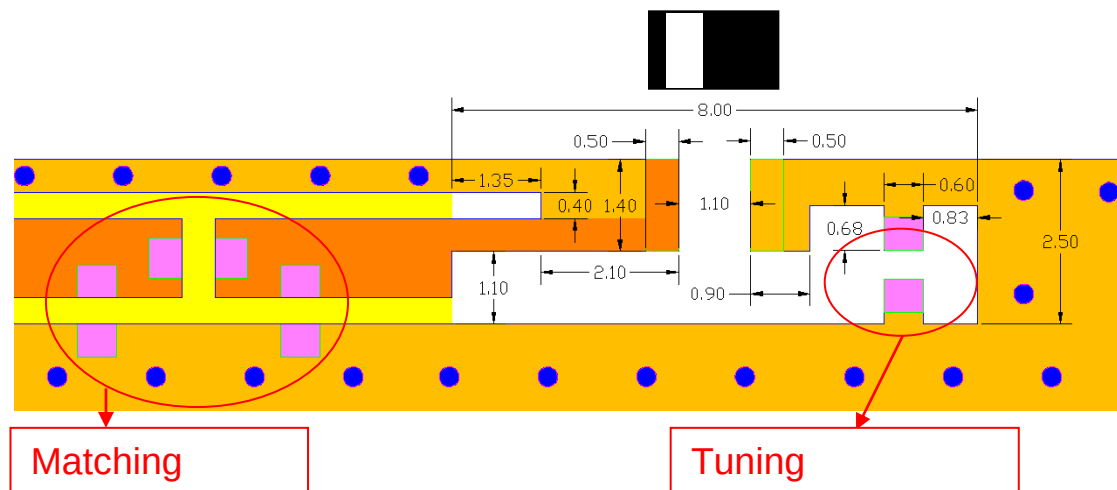
Layout Dimensions in Clearance area(Size=3.0*5.0mm)



FootPrint (Unit : mm)

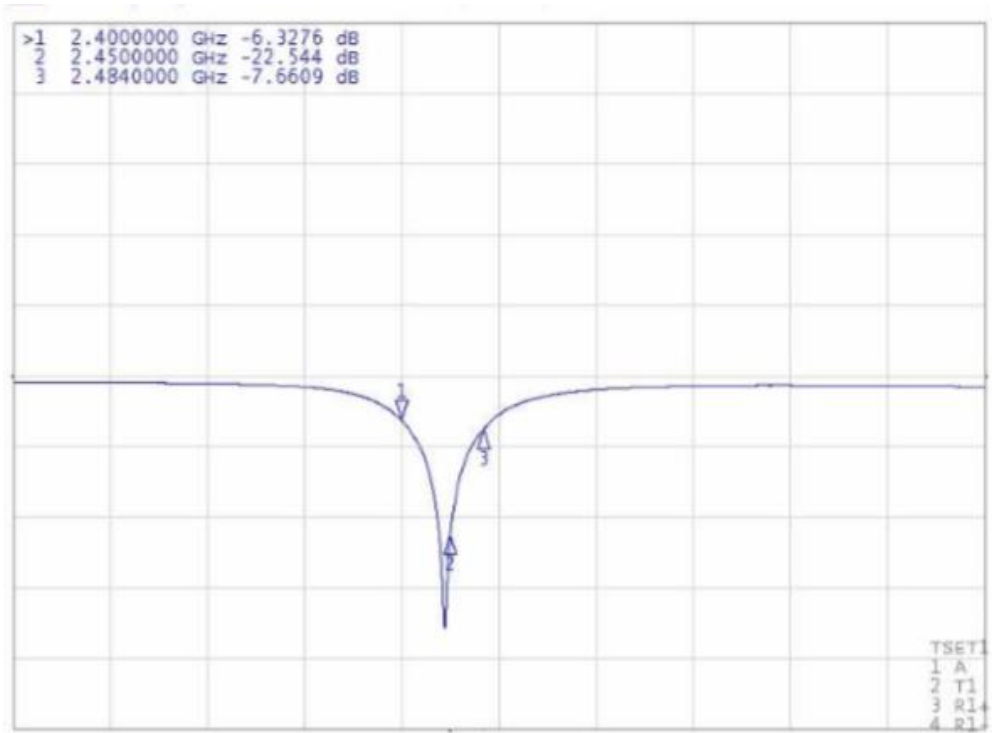


◆ 2nd Layout Dimensions in Clearance area(Size=8.0*2.5mm)

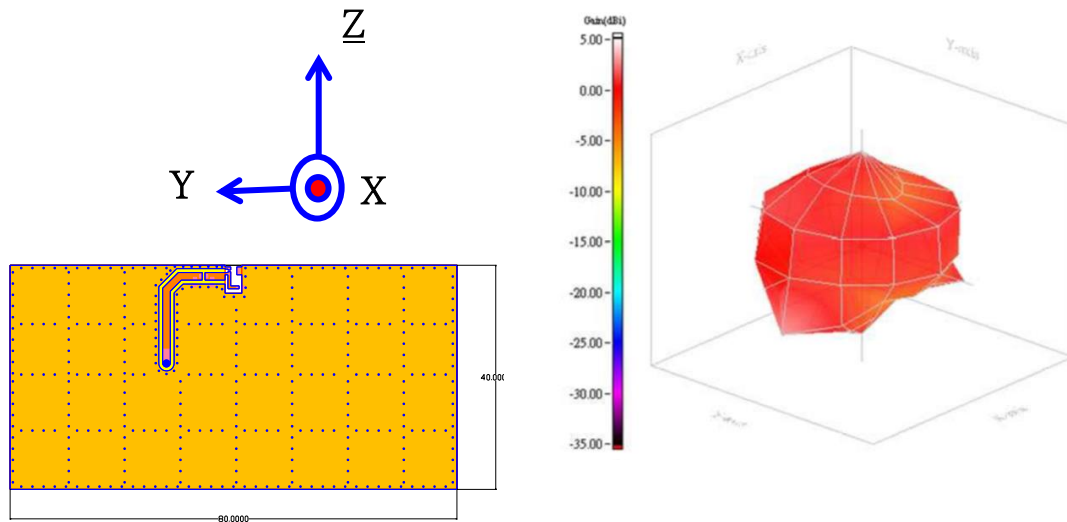


3. Measurement Results

Return Loss

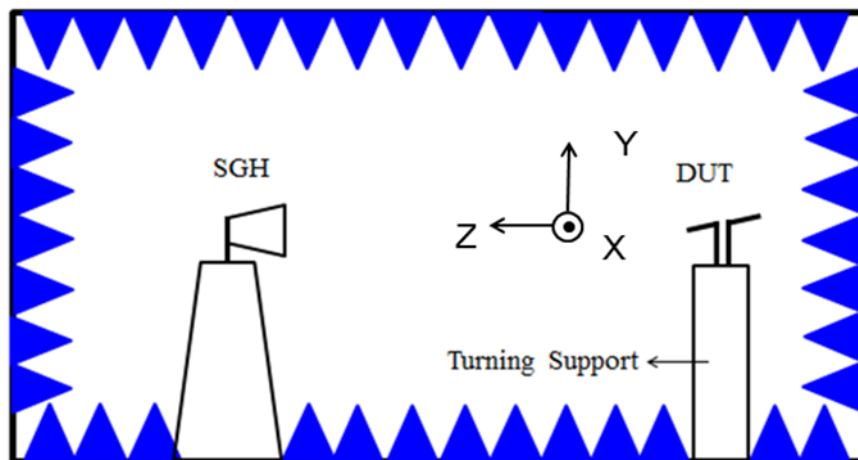


Radiation Pattern

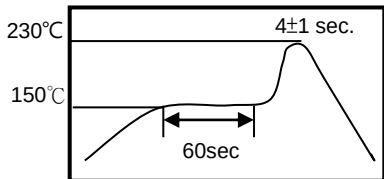
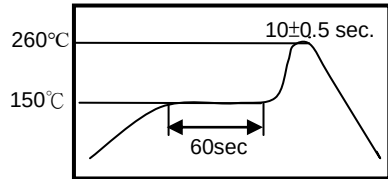


	Efficiency	Peak Gain	Directivity
2450MHz	70.56 %	1.72dBi	2.26 dBi

Chamber Coordinate System

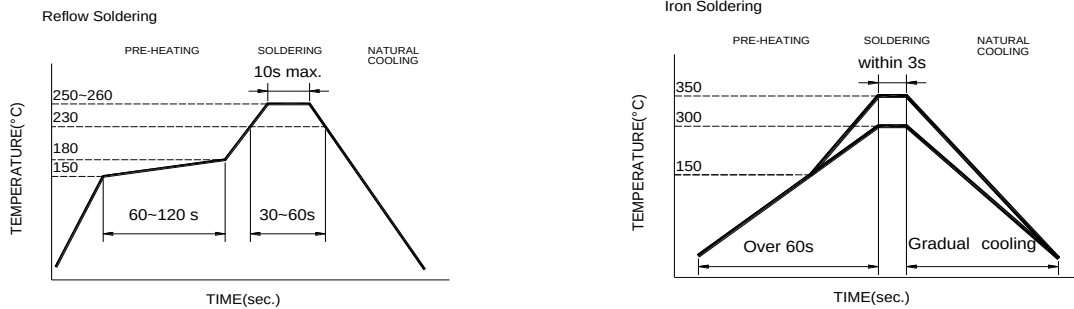


4. Reliability and Test Conditions

ITEM	REQUIREMENTS	TEST CONDITION															
Solderability	1. Wetting shall exceed 90% coverage 2. No visible mechanical damage TEMP (°C) 	Pre-heating temperature: 150°C/60sec. Solder temperature: 230±5°C Duration: 4±1sec. Solder: Sn-Ag3.0-Cu0.5 Flux for lead free: rosin															
Solder heat Resistance	1. No visible mechanical damage 2. Central Freq. change :within ± 6% TEMP (°C) 	Pre-heating temperature: 150°C/60sec. Solder temperature: 260±5°C Duration: 10±0.5sec. Solder: Sn-Ag3.0-Cu0.5 Flux for lead free: rosin															
Component Adhesion (Push test)	1. No visible mechanical damage	The device should be reflow soldered (230±5°C for 10sec.) to a tinned copper substrate. A dynamometer force gauge should be applied the side of the component. The device must with-ST-F 0.5 Kg without failure of the termination attached to component.															
Component Adhesion (Pull test)	1. No visible mechanical damage	Insert 10cm wire into the remaining open eye bend, the ends of even wire lengths upward and wind together. Terminal shall not be remarkably damaged.															
Thermal shock	1. No visible mechanical damage 2. Central Freq. change :within ±6% <table border="1" data-bbox="362 1205 788 1453"> <thead> <tr> <th>Phase</th><th>Temperature(°C)</th><th>Time(min)</th></tr> </thead> <tbody> <tr> <td>1</td><td>+85±5°C</td><td>30±3</td></tr> <tr> <td>2</td><td>Room Temperature</td><td>Within 3sec</td></tr> <tr> <td>3</td><td>-40±2°C</td><td>30±3</td></tr> <tr> <td>4</td><td>Room Temperature</td><td>Within 3sec</td></tr> </tbody> </table>	Phase	Temperature(°C)	Time(min)	1	+85±5°C	30±3	2	Room Temperature	Within 3sec	3	-40±2°C	30±3	4	Room Temperature	Within 3sec	+85°C => 30±3min -40°C => 30±3min Test cycle: 10 cycles The chip shall be stabilized at normal condition for 2~3 hours before measuring.
Phase	Temperature(°C)	Time(min)															
1	+85±5°C	30±3															
2	Room Temperature	Within 3sec															
3	-40±2°C	30±3															
4	Room Temperature	Within 3sec															
Resistance to High Temperature	1. No visible mechanical damage 2. Central Freq. change :within ±6% 3. No disconnection or short circuit.	Temperature: 85±5°C Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring.															
Resistance to Low Temperature	1. No visible mechanical damage 2. Central Freq. change :within ±6% 3. No disconnection or short circuit.	Temperature: -40±5°C Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring.															
Humidity	1. No visible mechanical damage 2. Central Freq. change :within ±6% 3. No disconnection or short circuit.	Temperature: 40±2°C Humidity: 90% to 95% RH Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring.															

5.Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.



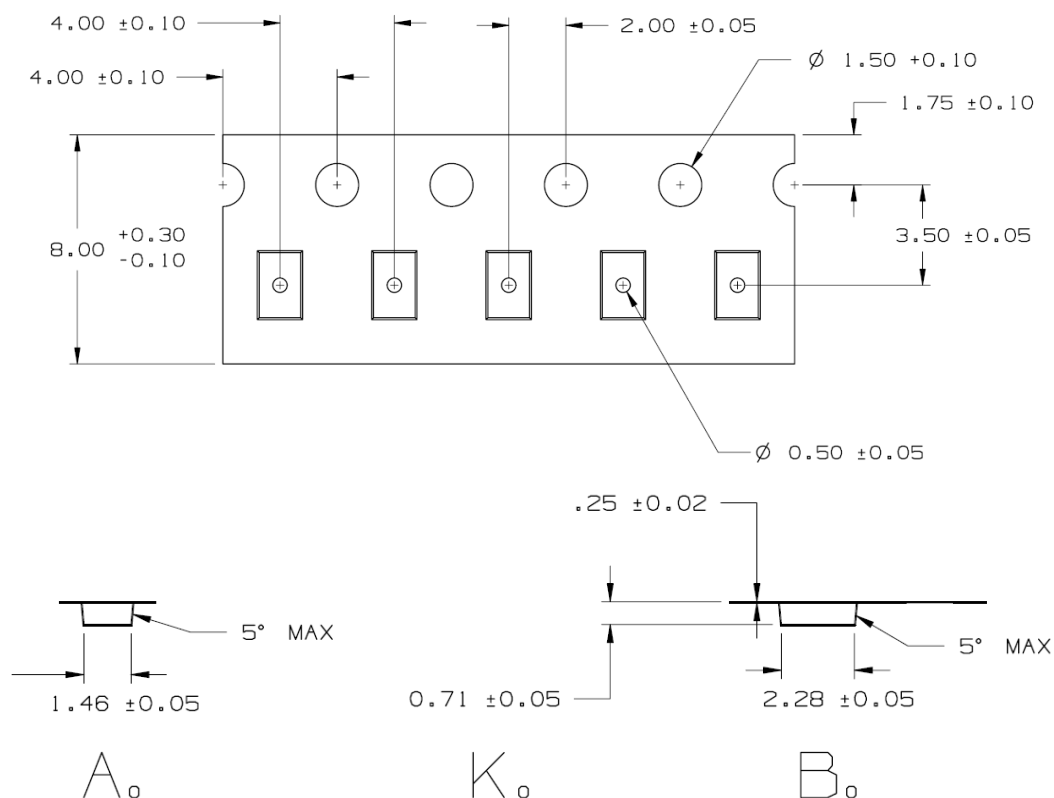
Recommended temperature profiles for re-flow soldering in Figure 1.

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

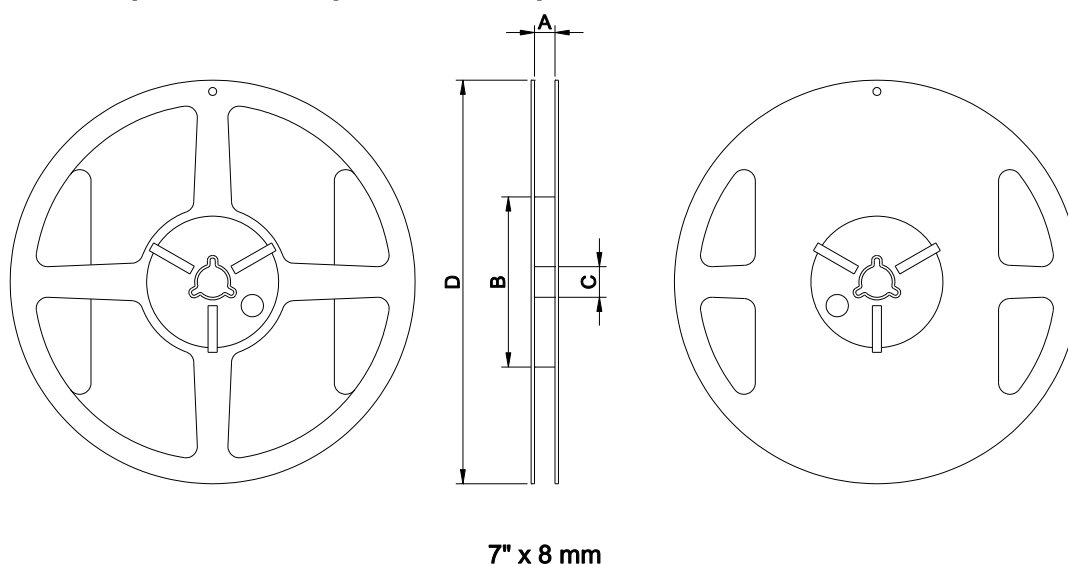
- Preheat circuit and products to 150°C
- Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- 1.0mm tip diameter (max)
- Limit soldering time to 3 sec.

6. Packaging Information

Tape Specification:



Reel Specification: (7", $\phi 180 \text{ mm}$)



Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0 ± 0.5	60 ± 2	13.5 ± 0.5	178 ± 2	3000

7.Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

1. Temperature and humidity conditions: -10~ 40℃ and 30~70% RH.
2. Recommended products should be used within 6 months from the time of delivery.
3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
3. Bulk handling should ensure that abrasion and mechanical shock are minimized.